Plain bearings — Metallic multilayer plain bearings —

Part 1: Non-destructive ultrasonic testing of bond of thickness greater than or equal to 0,5 mm

Paliers lisses — Paliers lisses métalliques multicouches —
Partie 1: Contrôle non destructif aux ultrasons des défauts d'adhérence d'épaisseur supérieure ou égale à 0,5 mm
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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular, the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights. Details of any patent rights identified during the development of the document will be in the Introduction and/or on the ISO list of patent declarations received (see www.iso.org/patents).

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation of the voluntary nature of standards, the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO’s adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT), see www.iso.org/iso/foreword.html.

This document was prepared by Technical Committee ISO/TC 123, Plain bearings, Subcommittee SC 2, Materials and lubricants, their properties, characteristics, test methods and testing conditions.

This fourth edition cancels and replaces the third edition (ISO 4386-1:2012), of which it constitutes a minor revision. The changes compared to the previous edition are as follows:

— Adjustment to the ISO Directives, including the implementation of Clause 3 Terms and definitions.

A list of all parts in the ISO 4386 series can be found on the ISO website.

Any feedback or questions on this document should be directed to the user’s national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.
Plain bearings — Metallic multilayer plain bearings —

Part 1:
Non-destructive ultrasonic testing of bond of thickness greater than or equal to 0,5 mm

1 Scope
This document specifies an ultrasonic testing method for determining bond defects between the bearing metal and the backing. The test can be performed on metallic multilayer plain bearings consisting of steel- or copper-based material backings lined with bearing metal based on lead and tin, with layer thicknesses greater than or equal to 0,5 mm. For cast iron backings, this document is applicable with restrictions.

The ultrasonic signal reflected by the bond interface between the bearing metal and the backing is used to determine bonding defects.

Ultrasonic testing is not possible on edge zones of sliding surface, flange sides, joint areas, oil holes, grooves, etc. in a range of less than half the diameter of the ultrasonic probe because of undefined reflections. The same applies to bearings with dovetail keying grooves at the bond. Ultrasonic testing of bond does not apply along the edges of the dovetails.

Evaluation of the bond on the visible transition from the backing to the bearing metal (on end faces or joint faces) is only practicable by the penetrant testing method specified in ISO 4386-3.

This document only describes in detail the pulse-echo method. Within the meaning of this document, the ultrasonic method only permits a qualitative evaluation of the bonding and not a quantitative determination of the bond strength. The ultrasonic bond test differs only between bond and bond defect.

2 Normative references
The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 4386-3, Plain bearings — Metallic multilayer plain bearings — Part 3: Non-destructive penetrant testing

3 Terms and definitions
No terms and definitions are listed in this document.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:
— ISO Online browsing platform: available at https://www.iso.org/obp

4 Symbols
The following symbol is used in this document.

Ra  Surface roughness
5 Test equipment

5.1 Ultrasonic instrument

Pulse-echo ultrasonic instrument using rectified A-scope presentation shall be used for the test. The instrument shall be fitted with a calibrated attenuator, reading in decibels, and adjustable time base ranges.

5.2 Probe

For the standard procedure, normal beam probes shall be chosen with size and frequency in relation to the thickness of the bearing layer, backing thickness and backing material. The typical range of diameters is from 24 mm for 2 MHz to 6 mm for 10 MHz probes. For layer thickness < 1 mm, testing with dual-element probes may be chosen.

5.3 Reference block

The time base range shall be adjusted, using a reference block corresponding to the thicknesses of the bearing to be inspected.

6 Preparation of test surface

The test surface shall have a surface roughness of $Ra \leq 5 \, \mu m$. After machining, remove dirt and oil using suitable cleaning agents.

7 Testing

7.1 General

Test plain bearings using either contact scanning, with light machine oil as a couplant, or using immersion scanning. Suppression and swept-gain functions shall be switched off. The preferred test is performed from the bearing metal side under consideration of the back-wall echo. Bearings with smaller diameters can be difficult to inspect by contact scanning from the bearing metal side because of limited access of the ultrasonic probe. In such a case, contact scanning from the back surface may be used.

7.2 Testing with a back-wall echo

General preconditions are:

a) free access with the probe to the contact surface;

b) back-wall is always parallel to the bearing metal surface;

c) no hollow spaces within the backing material (drilled holes, channels, etc.).

The time base range and sensitivity shall be adjusted so that at least the first back-wall echo is visible on the right-hand side of the screen at approximately 80 % of full screen height. In Figure 1, the bond echo (BE) is on the left-hand side of the screen near the input signal (IS). If in doubt about having the first back-wall echo (WE1) on the screen, use a reference block for adjustment.

Bond defect is given when the back-wall echo breaks down and at the same time, the bond echo on the left-hand side of the screen increases and repeats multiple times (see Figure 1). The border of the detected defect area is on the middle of the probe diameter when the back-wall echo is reduced to its half height under the above-mentioned conditions.